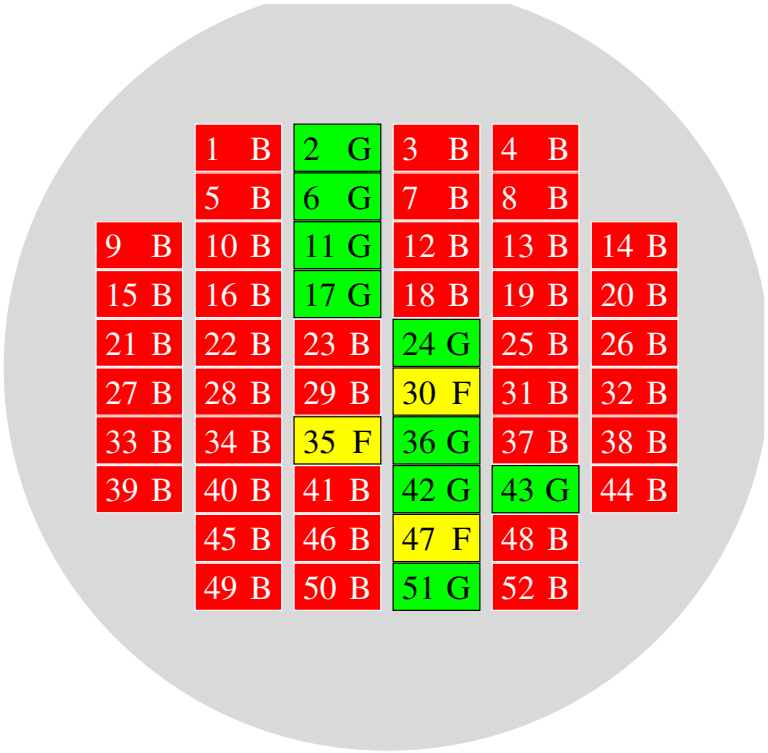
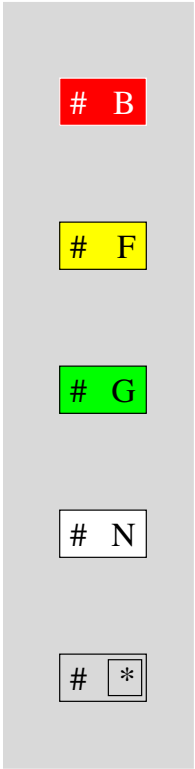
Die quality map for wafer 56 s/n: 21316-06-17

Date: 01/05/99





Bad die

Fair die

Good die

No info

Manually tagged